

FDME910PZT

February 2015

P-Channel PowerTrench® MOSFET -20 V, -8 A, 24 m Ω

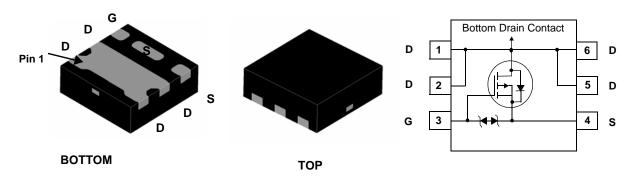
Features

- Max $r_{DS(on)}$ = 24 m Ω at V_{GS} = -4.5 V, I_D = -8 A
- Max $r_{DS(on)} = 31 \text{ m}\Omega$ at $V_{GS} = -2.5 \text{ V}$, $I_D = -7 \text{ A}$
- Max $r_{DS(on)}$ = 45 m Ω at V_{GS} = -1.8 V, I_D = -6 A
- Low profile: 0.55 mm maximum in the new package MicroFET 1.6x1.6 Thin
- HBM ESD protection level > 2 kV typical (Note 3)
- Free from halogenated compounds and antimony oxides
- RoHS Compliant



General Description

This device is designed specifically for battery charging or load switching in cellular handset and other ultraportable applications. It features a MOSFET with low on-state resistance and zener diode protection against ESD. The MicroFET 1.6x1.6 Thin package offers exceptional thermal performance for its physical size and is well suited to switching and linear mode applications.



MicroFET 1.6x1.6 Thin

MOSFET Maximum Ratings TA = 25 °C unless otherwise noted

Symbol	Paran		Ratings	Units	
V _{DS}	Drain to Source Voltage			-20	V
V_{GS}	Gate to Source Voltage			±8	V
I _D	-Continuous	T _A = 25°C	(Note 1a)	-8	^
	-Pulsed			-32	A
Б	Power Dissipation	T _A = 25°C	(Note 1a)	2.1	W
P_{D}	Power Dissipation	T _A = 25°C	(Note 1b)	0.7	VV
T _J , T _{STG}	Operating and Storage Junction Tempe	rature Range		-55 to +150	°C

Thermal Characteristics

$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1a)	60	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1a)	175	C/VV

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
E91	FDME910PZT	MicroFET 1.6x1.6 Thin	7 "	8 mm	5000 units

Electrical Characteristics $T_J = 25$ °C unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Chara	acteristics					
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = -250 \mu A, V_{GS} = 0 V$	-20			V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	I_D = -250 μA, referenced to 25 °C		-16		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = -16 V, V _{GS} = 0 V			-1	μΑ
I _{GSS}	Gate to Source Leakage Current	$V_{GS} = \pm 8 \text{ V}, V_{DS} = 0 \text{ V}$			±10	μΑ

On Characteristics

$V_{GS(th)}$	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = -250 \mu A$	-0.4	-0.6	-1.5	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	I_D = -250 μ A, referenced to 25 °C		2.7		mV/°C
	Static Drain to Source On Resistance	$V_{GS} = -4.5 \text{ V}, I_D = -8 \text{ A}$		20	24	mΩ
r		$V_{GS} = -2.5 \text{ V}, I_D = -7 \text{ A}$		25	31	
r _{DS(on)}		$V_{GS} = -1.8 \text{ V}, I_D = -6 \text{ A}$		32	45	
		$V_{GS} = -4.5 \text{ V}, I_D = -8 \text{ A}, T_J = 125 ^{\circ}\text{C}$		26	36	
9 _{FS}	Forward Transconductance	$V_{DD} = -5 \text{ V}, I_{D} = -8 \text{ A}$		38		S

Dynamic Characteristics

C _{iss}	Input Capacitance	V 40.V V 0.V	1586	2110	pF
C _{oss}	Output Capacitance	$V_{DS} = -10 \text{ V}, V_{GS} = 0 \text{ V},$ f = 1 MHz	236	355	pF
C _{rss}	Reverse Transfer Capacitance	1 - 1 1/11/12	218	330	pF

Switching Characteristics

t _{d(on)}	Turn-On Delay Time		9	18	ns
t _r	Rise Time	$V_{DD} = -10 \text{ V}, I_{D} = -8 \text{ A},$ $V_{GS} = -4.5 \text{ V}, R_{GEN} = 6 \Omega$	11	20	ns
t _{d(off)}	Turn-Off Delay Time	V _{GS} = -4.5 V, R _{GEN} = 0.12	87	139	ns
t _f	Fall Time		46	74	ns
Q_g	Total Gate Charge	$V_{GS} = -4.5 \text{ V}, V_{DD} = -10 \text{ V},$	15	21	nC
Q _{gs}	Gate to Source Charge	I _D = -8 A	2.2		nC
Q_{gd}	Gate to Drain "Miller" Charge		3.6		nC

Drain-Source Diode Characteristics

V _{SD} Source to Drain Diode Forward Vol	Source to Drain Diode, Ferward Voltage	$V_{GS} = 0 \text{ V}, I_{S} = -8 \text{ A}$	(Note 2)	-0.57	-0.8	-1.2	V
	Source to Drain blode Polward voltage	$V_{GS} = 0 \text{ V}, I_{S} = -1.8 \text{ A}$	(Note 2)		-0.7	-1.2	٧
t _{rr}	Reverse Recovery Time	I _F = -8 A, di/dt = 100 A/μs			17	31	ns
Q _{rr}	Reverse Recovery Charge				4.1	10	nC

¹ R_{0LA} is determined with the device mounted on a 1 in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. R_{0LC} is guaranteed by design while R_{0CA} is determined by the user's board design.



a. 60 °C/W when mounted on a 1 in² pad of 2 oz copper.



b. 175 °C/W when mounted on a minimum pad of 2 oz copper.

- 2. Pulse Test: Pulse Width < 300 $\mu\text{s},$ Duty cycle < 2.0%.
- 3. The diode connected between the gate and source serves only as protection ESD. No gate overvoltage rating is implied.

Typical Characteristics $T_J = 25$ °C unless otherwise noted

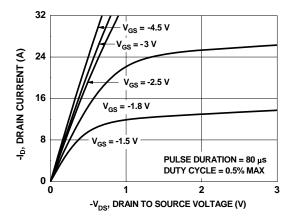


Figure 1. On Region Characteristics

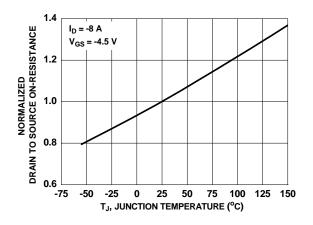


Figure 3. Normalized On Resistance vs Junction Temperature

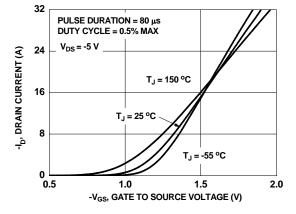


Figure 5. Transfer Characteristics

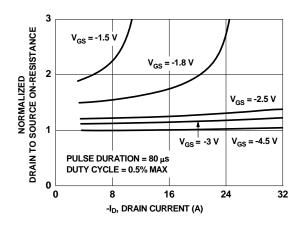


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

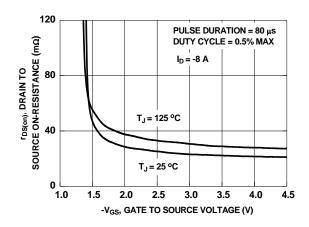


Figure 4. On-Resistance vs Gate to Source Voltage

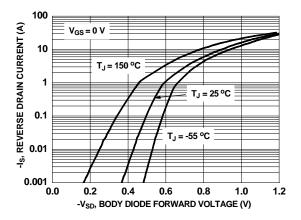


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

Typical Characteristics $T_J = 25$ °C unless otherwise noted

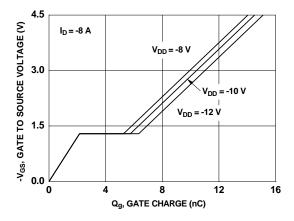


Figure 7. Gate Charge Characteristics

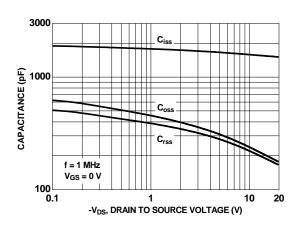


Figure 8. Capacitance vs Drain to Source Voltage

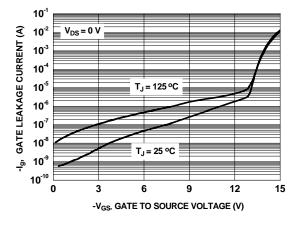


Figure 9. Gate Leakage Current vs Gate to Source Voltage

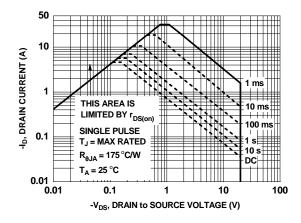


Figure 10. Forward Bias Safe Operating Area

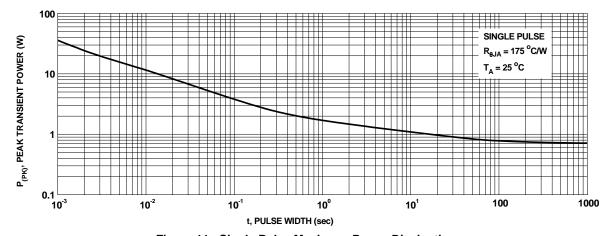


Figure 11. Single Pulse Maximum Power Dissipation

Typical Characteristics T_J = 25 °C unless otherwise noted

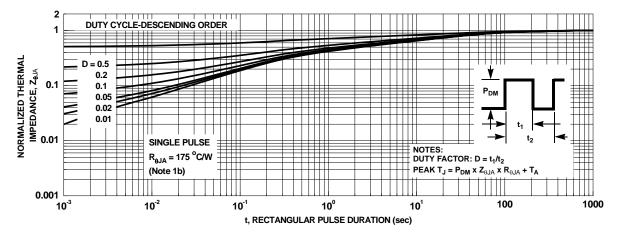
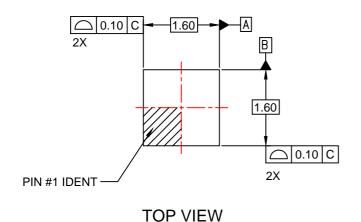
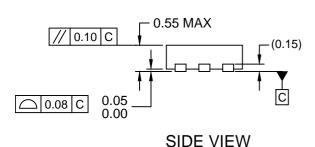
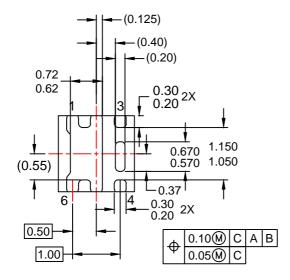


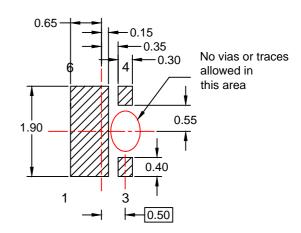
Figure 12. Junction-to-Ambient Transient Thermal Response Curve



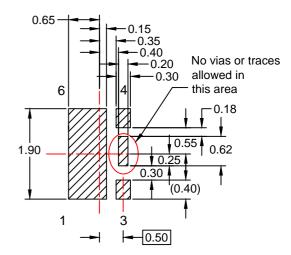




BOTTOM VIEW



RECOMMENDED LAND PATTERN OPT 1



RECOMMENDED LAND PATTERN OPT 2

NOTES:

- A. DOES NOT FULLY CONFORM TO JEDEC REGISTRATION
- B. DIMENSIONS ARE IN MILLIMETERS.
- C. DIMENSIONS AND TOLERANCES PER ASME Y14.5M, 1994.
- D. LAND PATTERN RECOMMENDATION IS BASED ON FSC DESIGN ONLY
- E. DRAWING FILENAME: MKT-UMLP06Frev6





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Rev. 173

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